Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/069,792	BUERCK ET AL.		
Examiner	Art Unit		
Quynh H. Nguyen	2614		

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SEARCHED					
Class	Subclass	Date	Examiner		
379	220.01 221.01	7/13/2006	QN		
370	395.2 395.21 352	7/13/06	QN		
above	updated	1/17/2007	QN		
above	updated	5/8/2007	QN		
	1		 		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
379	220.01 221	5/8/07	QN	
370	395.2 395.21 352	5/8/07	QN	
	e searched printout	5/8/07	QN	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Searched: East, USPGPub, USPAT	7/13/06	QN		
Inventor searched through PALLM database	7/13/06	QN		